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## **Nano and MEMS Sensors**

Guest Editor:

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# Message from the Guest Editor

Dear Colleagues,

The manufacturing and integration of autonomous and embedded sensors through a combination of micro- and nanosystem technologies have been revolutionizing self-powered, high bandwidth devices for advance manufacturing (AM), artificial intelligence (AI), and IoT.

More specifically, nano and MEMS sensors are the building blocks for a vast range of applications, from continuous real-time health (wearable) and environmental monitoring (gas, pressure, temperature, etc.) to enabling embedded mobile Internet services (wireless), including smart/connected cars and unattended vehicles (UAV) (inertial). As these devices have numbered in the tens of billions, the potential for disruptive innovation has been immense

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Prof. Dr. Mustafa Yavuz Guest Editor









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